



Dual N-Channel 60-V (D-S) 175 °C MOSFET

PRODUCT SUMMARY					
V _{DS} (V)	$R_{DS(on)}(\Omega)$	I _D (A)	Q _g (Typ.)		
60	0.041 at V _{GS} = 10 V	6.5	9.2 nC		
	0.052 at V _{GS} = 4.5 V	5.8	9.2110		

0.052 at V_{GS} = 4.5 V 5.8 S0-8 S₁ 1 8 D₁

Top View

Ordering Information: Si4946BEY-T1-E3 (Lead (Pb)-free)

Si4946BEY-T1-GE3 (Lead (Pb)-free and Halogen-free)

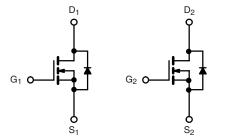
 D_1 D_2 D_2

FEATURES

- Halogen-free According to IEC 61249-2-21 Definition
- TrenchFET[®] Power MOSFET
- 175 °C Maximum Junction Temperature
- 100 % R_q Tested
- Compliant to RoHS directive 2002/95/EC







N-Channel MOSFET

N-Channel MOSFET

Parameter		Symbol	Limit	Unit
Drain-Source Voltage	V _{DS}	60	V	
Gate-Source Voltage		V _{GS}		± 20
	T _C = 25 °C		6.5	
Continuous Proin Current /T 150 °C)	T _C = 70 °C		5.5	
Continuous Drain Current (T _J = 150 °C)	T _A = 25 °C	I _D	5.3 ^{a, b}	
	T _A = 70 °C		4.4 ^{a, b}	
Pulsed Drain Current		I _{DM}	30	A .
Continuous Courses Busin Binds Coursest	T _C = 25 °C		3.1	
Continuous Source Drain Diode Current	T _A = 25 °C	I _S	2 ^{a, b}	
Avalanche Current	1 0.1 ml 1	I _{AS}	12	
Single-Pulse Avalanche Energy	L = 0 1 mH	E _{AS}	7.2	mJ
	T _C = 25 °C		3.7	
Maximum Power Dissipation	T _C = 70 °C	В	2.6	
	T _A = 25 °C	P _D	2.4 ^{a, b}	W
	T _A = 70 °C		1.7 ^{a, b}	
Operating Junction and Storage Temperature R	T _J , T _{stg}	- 55 to 175	°C	

THERMAL RESISTANCE RATINGS						
Parameter	Symbol	Typical	Maximum	Unit		
Maximum Junction-to-Ambient ^{a, c}	t ≤ 10 s	R _{thJA}	50	62.5	°C/W	
Maximum Junction-to-Foot (Drain)	Steady State	R _{thJF}	33	41	C/VV	

Notes:

- a. Surface Mounted on 1" x 1" FR4 board.
- b. t = 10 s.
- c. Rework Conditions: manual soldering with a soldering iron is not recommended for leadless components.
- d. Maximum under Steady State conditions is 110 °C/W.

Si4946BEY

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Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit	
Static					•		
Drain-Source Breakdown Voltage	V_{DS}	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$	60			V	
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	L = 250 uA		53		mV/°C	
V _{GS(th)} Temperature Coefficient	$\Delta V_{GS(th)}/T_{J}$	I _D = 250 μA		- 6.7			
Gate-Source Threshold Voltage	V _{GS(th)}	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$	1.0	2.4	3.0	V	
Gate-Source Leakage	I _{GSS}	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 20 \text{ V}$			± 100	nA	
Zana Oata Valla va Durin Oamant		V _{DS} = 60 V, V _{GS} = 0 V			1		
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} = 60 V, V _{GS} = 0 V, T _J = 55 °C			10	μΑ	
On-State Drain Current ^a	I _{D(on)}	$V_{DS} \ge 5 \text{ V}, V_{GS} = 10 \text{ V}$	30			Α	
		$V_{GS} = 10 \text{ V}, I_D = 5.3 \text{ A}$		0.033 0.041		+	
Drain-Source On-State Resistance ^a	R _{DS(on)}	V _{GS} = 4.5 V, I _D = 4.7 A		0.041	0.052	Ω	
Forward Transconductance ^a	g _{fs}	V _{DS} = 15 V, I _D = 5.3 A		24		S	
Dynamic ^b	<u> </u>			<u> </u>		1	
Input Capacitance	C _{iss}			840		pF	
Output Capacitance	C _{oss}	V _{DS} = 30 V, V _{GS} = 0 V, f = 1 MHz		71			
Reverse Transfer Capacitance	C _{rss}			44			
	Qg	$V_{DS} = 30 \text{ V}, V_{GS} = 10 \text{ V}, I_D = 5.3 \text{ A}$		17	25	25 12 nC	
Total Gate Charge				9.2	12		
Gate-Source Charge	Q _{gs}	$V_{DS} = 30 \text{ V}, V_{GS} = 5 \text{ V}, I_{D} = 5.3 \text{ A}$		3.3			
Gate-Drain Charge	Q_{gd}			3.7			
Gate Resistance	R_g	f = 1 MHz	3.1	6.5	9.5	Ω	
Turn-On Delay Time	t _{d(on)}			20	30		
Rise Time	t _r	$V_{DD} = 30 \text{ V}, R_{L} = 6.8 \Omega$		120	180		
Turn-Off Delay Time	t _{d(off)}	$I_D \cong 4.4 \text{ A}, V_{GEN} = 4.5 \text{ V}, R_g = 1 \Omega$		20	30	1	
Fall Time	t _f			30	45		
Turn-On Delay Time	t _{d(on)}			10	15	ns	
Rise Time	t _r	V_{DD} = 30 V, R_L = 6.8 Ω		12	20		
Turn-Off Delay Time	t _{d(off)}	$I_D \cong 4.4 \text{ A}, V_{GEN} = 10 \text{ V}, R_g = 1 \Omega$		25	40		
Fall Time	t _f			10	15	1	
Drain-Source Body Diode Characteris	tics	-		•		•	
Continuous Source-Drain Diode Current	I _S	T _C = 25 °C			3.1	Λ	
Pulse Diode Forward Current ^a	I _{SM}				30	A	
Body Diode Voltage	V_{SD}	I _S = 2 A		0.8	1.2	V	
Body Diode Reverse Recovery Time	t _{rr}			25	50	ns	
Body Diode Reverse Recovery Charge	Q _{rr}	I _F = 4.4 A, dl/dt = 100 A/μs, T _{.l} = 25 °C		25	50	nC	
Reverse Recovery Fall Time	t _a	$I_F = 4.4 \text{ A}, \text{ u/u} = 100 \text{ A/}\mu\text{s}, I_J = 25 ^{\circ}\text{C}$		18			
Reverse Recovery Rise Time	t _b			7		ns	

Notes:

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

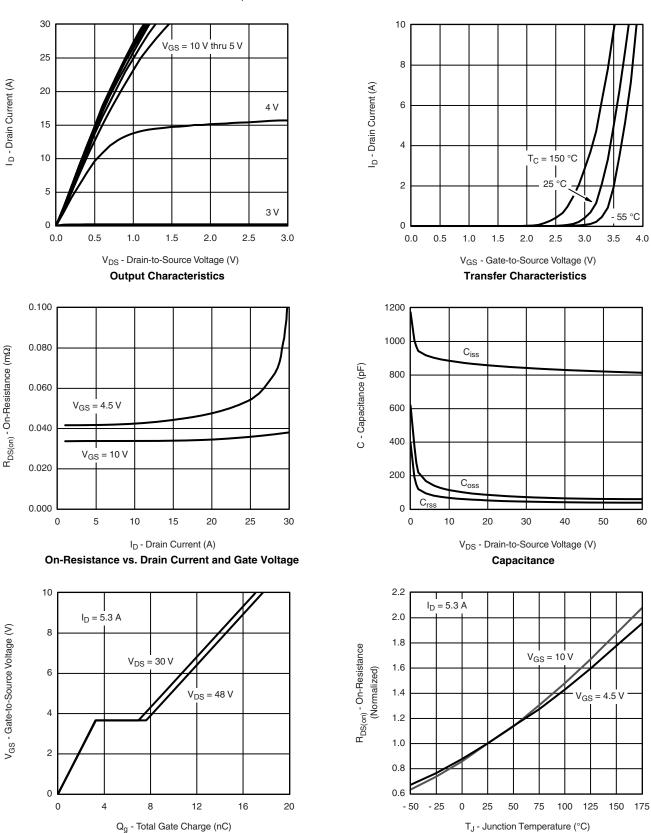
a. Pulse test; pulse width $\leq 300~\mu s,$ duty cycle $\leq 2~\%.$

b. Guaranteed by design, not subject to production testing.





TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

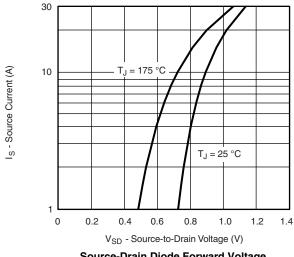


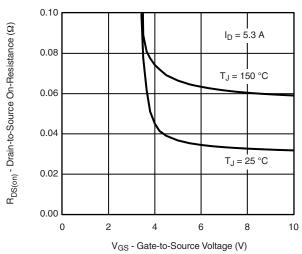
Gate Charge

On-Resistance vs. Junction Temperature

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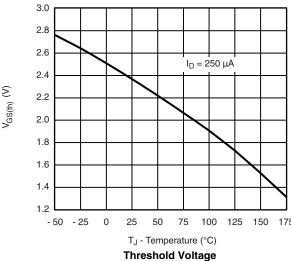
TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



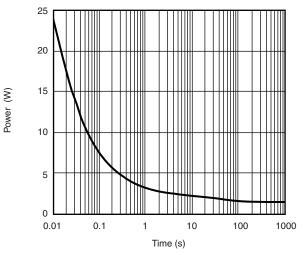


Source-Drain Diode Forward Voltage

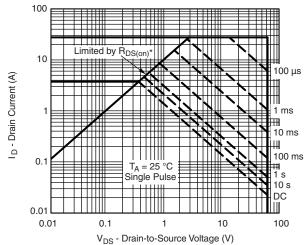




On-Resistance vs. Gate-to-Source Voltage



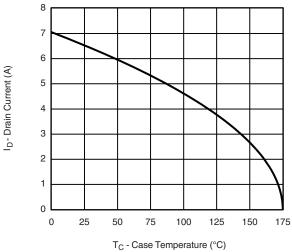
Single Pulse Power, Junction-to-Ambient

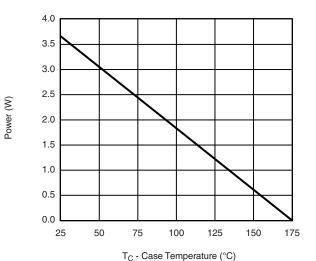


* V_{GS} > minimum V_{GS} at which $R_{DS(on)}$ is specified Safe Operating Area, Junction-to-Ambient



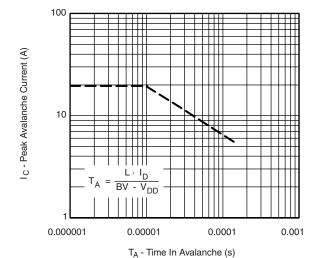
TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted





Current Derating*

Power, Junction-to-Case



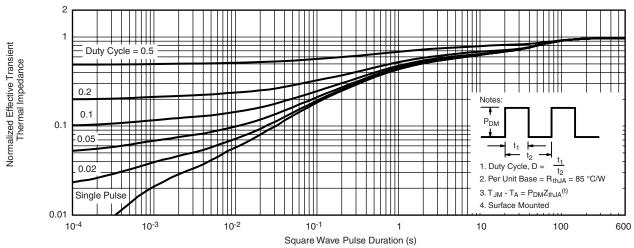
Single Pulse Avalanche Capability

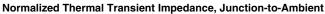
^{*} The power dissipation P_D is based on $T_{J(max)} = 175$ °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.

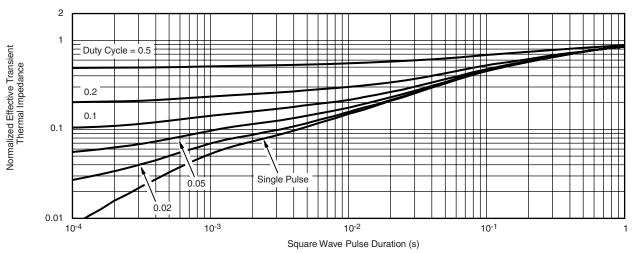
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TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted







Normalized Thermal Transient Impedance, Junction-to-Case

Vishay Siliconix maintains worldwide manufacturing capability. Products may be manufactured at one of several qualified locations. Reliability data for Silicon Technology and Package Reliability represent a composite of all qualified locations. For related documents such as package/tape drawings, part marking, and reliability data, see www.vishay.com/ppg273411.



SOIC (NARROW): 8-LEAD JEDEC Part Number: MS-012







	MILLIMETERS INCHES			HES		
DIM	Min	Max	Min	Max		
Α	1.35	1.75	0.053	0.069		
A ₁	0.10	0.20	0.004	0.008		
В	0.35	0.51	0.014	0.020		
С	0.19	0.25	0.0075	0.010		
D	4.80	5.00	0.189	0.196		
Е	3.80	4.00	0.150	0.157		
е	1.27	1.27 BSC		0.050 BSC		
Н	5.80	6.20	0.228	0.244		
h	0.25	0.50	0.010	0.020		
L	0.50	0.93	0.020	0.037		
q	0°	8°	0°	8°		
S	0.44	0.64	0.018	0.026		
ECN: C-06527-Rev. I. 11-Sep-06						

DWG: 5498

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RECOMMENDED MINIMUM PADS FOR SO-8



Recommended Minimum Pads Dimensions in Inches/(mm)

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